

Notice of References Cited	Application/Control No. 10/644,838		Applicant(s)/Patent Under Reexamination CHEN, CHIH-JU	
	Examiner Alix Elizabeth Echelmeyer		Art Unit 1745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0115519	06-2004	Lee, Sung Hun	429/061
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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